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APPLICATION NO.	FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/761,484	(01/20/2004	Timothy Henson	IR-2364 2919		
2352	7590	09/22/2004		EXAMINER		
		ER GERB & SOFF HE AMERICAS	ERDEM, FAZLI			
NEW YOR				ART UNIT PAPER NUMBER		
				2826		

DATE MAILED: 09/22/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

)							
Office Action Summary		Application No.	Applicant(s)				
		10/761,484	HENSON, TIMOTHY				
		Examiner	Art Unit				
		Fazli Erdem	2826				
The MAILING DA	TE of this communication app	ears on the cover sheet wi	th the correspondence address	S			
THE MAILING DATE O - Extensions of time may be ava after SIX (6) MONTHS from th - If the period for reply specified - If NO period for reply is specifie - Failure to reply within the set o	JTORY PERIOD FOR REPLY F THIS COMMUNICATION. ilable under the provisions of 37 CFR 1.13 e mailing date of this communication. above is less than thirty (30) days, a reply ed above, the maximum statutory period w r extended period for reply will, by statute, e later than three months after the mailing . See 37 CFR 1.704(b).	6(a). In no event, however, may a rowithin the statutory minimum of thirtill apply and will expire SIX (6) MON cause the application to become AB	eply be timely filed y (30) days will be considered timely. THS from the mailing date of this commun ANDONED (35 U.S.C. § 133).	nication.			
Status							
1) Responsive to co	mmunication(s) filed on 20 Ja	nuary 2004.	,				
2a) This action is FIN	AL. 2b)⊠ This	action is non-final.					
3) Since this applica	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accorda	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims							
4)⊠ Claim(s) <u>1-17</u> is/a	re pending in the application.						
4a) Of the above of	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>1-17</u> is/a	·						
	7) Claim(s) is/are objected to.						
8) Claim(s) a	re subject to restriction and/or	election requirement.	•				
Application Papers							
9)☐ The specification i	s objected to by the Examiner		•	·			
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11)☐ The oath or declar	ration is objected to by the Ex	aminer. Note the attached	Office Action or form PTO-15	52.			
Priority under 35 U.S.C. §	.119		,				
a) All b) Some 1. Certified co 2. Certified co 3. Copies of the application	is made of a claim for foreign e* c) None of: pies of the priority documents pies of the priority documents ne certified copies of the prior from the International Bureau etailed Office action for a list of	have been received. have been received in A aty documents have been (PCT Rule 17.2(a)).	pplication No received in this National Stag	e			
Attachment(s)							
1) Notice of References Cited			ummary (PTO-413)				
	ent Drawing Review (PTO-948) ement(s) (PTO-1449 or PTO/SB/08))/Mail Date formal Patent Application (PTO-152)	ı			
Paper No(s)/Mail Date <u>1/20/</u>		6) Other:					

U.S. Patent and Trademark Office PTOL-326 (Rev. 1-04) Application/Control Number: 10/761,484

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DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-12 rejected under 35 U.S.C. 103(a) as being unpatentable over Hurkx et al. (6,541,817) in view of Ahlers et al. (6,667,514).

Regarding Claims 1-12, Hurkx et al. disclose a trench-gate semiconductor devices and their manufacture where in Fig. 1 it is disclose a semiconductor region of 14 formed over substrate, a semiconductor trench receiving region 10 formed over the semiconductor region 14, plurality of trenches 20 formed in the trench receiving region, each treanch including a buttom surface and sidewalls 20b, conductive material 61 and 62 formed inside the trenches, channel region 15 between the trenches, gate electrode 11, dielectric material 17 formed inside the trenches. Hurkx et al. fail to disclose the required charge balancing structure. However, Ahlers et al. disclose a semiconductor component with charge compensation structure and associated fabrication where in Fig. 8A, regions SP are charge balancing regions.

It would have been obvious to one of having ordinary skill in the art at the time the invention was made to include the required charge balancing structure in Hurkx et al. as taught by Ahlers et al. in order to have a power semiconductor structure with increased performance.

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3. Claims 13-17 rejected under 35 U.S.C. 103(a) as being unpatentable over Hurkx et al. (6,541,817) in view of Luo (6,495,421) further in view of Ahlers et al. (6,667,514).

Regarding Claims 13-17, Hurkx et al. disclose a trench-gate semiconductor devices and their manufacture where in Fig. 1 it is disclose a semiconductor region of 14 formed over substrate, a semiconductor trench receiving region 10 formed over the semiconductor region 14, plurality of trenches 20 formed in the trench receiving region, each treanch including a buttom surface and sidewalls 20b, conductive material 61 and 62 formed inside the trenches, channel region 15 between the trenches, gate electrode 11, dielectric material 17 formed inside the trenches. Hurkx et al. fail to disclose the required method and required charge balancing structure. However, Luo discloses manufacture of semiconductor material and devices using that material where the required method is disclosed. Furthermore, Ahlers et al. disclose a semiconductor component with charge compensation structure and associated fabrication where in Fig. 8A, regions SP are charge balancing regions.

It would have been obvious to one of having ordinary skill in the art at the time the invention was made to include the required method and the required charge balancing structure in Hurkx et al. as taught by Luo and Ahlers et al. respectively in order to manufacture a power semiconductor structure with increased performance.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Fazli Erdem whose telephone number is (571) 272-1914. The examiner can normally be reached on M - F 8:00 - 5:00.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

September 19, 2004

NATHAN ELYNN
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800